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DDR-Dupe December 7,	1967
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U. S. Government	
o. b. dovermiens	
Attn: Mr. Bill K.	
	٠.
Gentlemen:	
The has reviewed your request	RD 10-68 TAT
for a Twin Stage On-Line PI Comparator (#02228) and is most pl	
to be responsive. We offer the attached proposal which describe	
our approach to the development of an instrument which will prov	
the Photo Interpreter with the added capability of obtaining preci measurements. It is both theoretically feasible and practical.	
eration will be given to obtaining the greatest possible flexibility	
usefulness.	
	STAT
QUALIFICATIONS OF THE	SIAI
We believe ourselves to be exceptionally well qualified to	under-
take this program for your Agency. Our capability and responsi	
to expressed needs are well demonstrated first by the instrumen	ts
already in your facilities and second, by those instruments provi	ded to
other Government Agencies, universities, and industry.	
These accomplishments include the design and manufactu	re of
complete systems with digital readout or preprogramming to me	et special
user needs. Of note, are the Type 1032 Microdensitomete	r with STAT
digital readout on magnetic tape for reconnaissance and re-entry	
photography data reduction; the Type 1205 Semiautomatic S Comparator, originally developed for satellite geodesy and since	
modified for terrain as well; the Type 1480 Photorepeater	
production of photomasks with very high resolution and large for	mat
geometries and a positional precision of 10 microinches or bette	r; the
Type 1600 Pattern Generator for the manufacture of reticle	
Type 1600 Pattern Generator for the manufacture of retici-	

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	e Setting Instrume	nt for reducing positional and	STAT						
and the Type 1300	density data from X-ray diffraction or spectrographic films or plates; and the Type 1300 On Line Interferogram Reader for analysis of supersonic and hypersonic windtunnel data. Most of these systems are								
supersonic and hyperso now standard products		ta. Most of these systems are	STAT						
design and manufacture photographic data reduc	of opto-electro-retion and creation	ledge and capabilities in the nechanical systems for precise we are confident that we can f the program described in the							
SPECIAL CONSIDERAT	CIONS								
ment Read-out System request. We propose a components and integra data handling capacity, accessibility for service for the proposed data a the-art and no unusual While this would mean total cost of the first unexpensive to the Govern	other than the modern readout ted circuits for the reduced heat discee, and high degree cquisition system difficulty is seen increased cost for the plus the larger ament than those of the cost of the cost of the cost of the cost for the co	ee of reliability. The requirem are well within the state-of- in meeting all these requirement the first unit, we expect the quantity lots would be less quantity prices quoted to us by	STAT						
	nt are best served	Furthermore, we believe the by one contractor having systems	em						
responsibility to the gr		lible as we have proposed. The ll company and subcontractor	STAT						
manufacturing capabilit of reliability under long	ties in the field of g term continuous	usage of systems manufacture	1						
for us ov It lends considerable so		years cannot be overemphasize	STAT						
		d to effectively augment our							
DEVELOPMENT AND	PRODUCTION CO	STS							
We are pleased	to provide a quot	ation for the development, man	a= stat						

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Comparator of an amount of for the sheets to be purchased are Net 30 days. Deliv	or Items 1 and from the	2, page 2 of th	a. This price include contract pricing Our terms receipt of yendor	STAT
items. For example, for the Stereo-viewer. 300 days delivery after	On this basis, receipt of ord	quotes a deli- our expected er. Delivery	very of 210 days delivery is 270 to within this period	STAT
will require extra effor quoted by days.	t on our part in this quot	n view of the lation is firm f	ong delivery schedu or a period of 60	ale STAT
We are pleased of the instrument in qu			oduction costs to you	u
	t of 5 instrument of 10 instrume			STAT
a lot	t of 15 instrument of 20 instrument	ents		
These estimates are by standard instrum. This information is interest.	ents in one-of-	\cdot a-kind and sm	hall multiple lots.	STAT o t
be construed as a firm	quotation. An	y quotation by		STAT STAT
well as labor, overhea	d, and G&A ra	tes at the time	of quotation.	
CONTRACTUAL CONS	<u>IDERATIONS</u>			
The No. DB-1001 of 31 Aug documentation; and wit	gust 1966 (Attac	chment l) rela		ion tat
the same date relating	to preparation	of technical n	nanuals.	•
INTEREST			,	
The Twin Stage PI Compar your capabilities. We real interest and wish timely fashion and to y	have studied a to provide this	cilities will co nd reviewed th instrument fo	ne requirements wit	STAT h
			Mincorola wouts	STAT .
ACT/mw			Director of Marke	ting

Enclosures

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TWIN	STAGE	ON-LINE	P
	COMP	ARATOR	

This proposal, furnished in response RD 10-68, shall not be disclosed outside the Government or be duplicated used or disclosed, in whole or in part, for any purposes other than to evaluate the proposal, provided, that if a contract is awarded to the offeror as a result of or in connection with the submission of this proposal, the Government shall have the right to duplicate, use, or disclose this proposal to the extent provided in the contract. This restriction does not limit the Government's right to use information contained in this proposal if it is obtained from another source.

Response to Request RD 10-68

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SUMMARY		
The spleased to respon RD 10-68 for a Twin Stage, On-Line, PI Comparabelieve it is both theoretically feasible and practic ment as described in this proposal. The instrument shall consist of a high performance stereo-viewing scanning stages, one of which is digitized for mean and a measurement read-out system.	tor (#02228). We cal to fabricate an instruent that we propose g system; two independer	
The viewing system shall be the stopermit increased separation of the two turret of approximately 18 in. This modification, in additing mentioned in this proposal, forms the basis for a we believe that use of the unmodified	on to the advantages	STAT
severely limit both present and future potential pe		* .
The scanning stages are to be designed and manufactorhiques employed by the for its high precision comparators. The range for common drive speeds shall be between 5 microns (1/1000 ratio) with a design goal for maximum spectarism maximum speed is selected on the basis that speeds coupled with the real need to maintain preminimum speed introduces unwarranted complexically, the requested positional accuracy of 1 part in	as a general practice r both independent and /sec and 5 mm/sec eed of 0.5 in./sec. the desire for very high cise control at the ty and expense. Addition	

The requirements for the proposed Data Acquisition System are well within the state of the art, and no unusual difficulty is seen in meeting all of the requirements. All of the techniques contemplated for use in the system have been fully tested and proven both by us and by others. We have designed and built a number of similar systems of equal or greater complexity. All of these systems have performed as intended and are in current use. It is recognized, however, that the proposed system is fairly complex and will require taking considerable care at all stages of design to insure a completely satisfactory result. Integrated circuits on plug-in cards will be used for performing nearly all functions. In those cases where integrated circuits are not suitable for use because of their limited power handling ability, semiconductor circuits using discrete components will be used. The TTL type circuit logic planned for this system affords a high degree of immunity to noise, high speed, and excellent reliability.

exceeded.

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It has been pointed out in the Request for Quotation that the Data Acquisition System has been completely designed. However, we believe the needs of the customer are best served by one contractor having system responsibility to the greatest extend possible with the minimum possible divided responsibility. For this reason, we propose a modern digital measurement readout system composed of solid state and integrated circuit components. While this would mean increased cost for the first unit, we expect subsequent units would be less expensive than those quantity prices quoted to us by	у
believes itself exceptionally well qualified to undertake this program for your Agency. Our capability is well demonstrated by the performance of instruments already in your facilities. We intend to provide you with a new instrument which will more than adequately meet your operational objectives.	STAT

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DESIGN FOR TWIN STAGE, ON-LINE PI COMPARATOR	STAT
INTRODUCTION	
A need exists for the development of an operational prototype Twin Stage On-Line PI Comparator. This need is based on the desire of the Photo Interpreter to measure small distances on film that has been cut out of exposures of interest. These and duplicate cut-outs (film chips) can be placed on the twin stage comparator and identification made with stereo aid of the desired point of measurement. Measurements then can be made without transfer of film chips to another instrument. Prior to the development of the twin stage comparator, the Photo Interpreter has simply identified the desired point of measurement and measurements were made by a separate group with higher precision comparators. Our understanding is that in the design of this instrument emphasis is to be placed on ease of operation, reliability, simplicity, measuring accuracy and reasonableness of price for production quantities of 10 or more. Proposes to provide your laboratory with an instrument based on the design objectives outlined in your request which will more than adequately meet your operational objectives.	STAT STAT
This shall be a compact stereo chip comparator incorporating a high performance stereo-viewing system, two independent scanning stages, one of which is digitized for measurement in two axes, and a measurement readout system.	
The two scanning stages shall have free aperture of 6 in. x 6 in. and full 6 in. x 6 in. (±3 in.) travel without interference. Design will include differential drive to accommodate measurements on chips of different scales.	
 The viewing system shall consist of the High Power Stereoviewer described in Attachment 3 of your request, modified to permit independent travel of both stages without interference and fine focus adjustment. The measurement read-out system shall be designed to be compatibly with the customer in-house computer on-line operation requirements as detailed in Attachment 5.	•
DETAILED DESCRIPTION	
Viewing System	

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In order to permit full 6 in. x 6 in. travel of both stages and still retain

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mechanical stability, we believe the separation of the optical center line of the two turrets on the stereo-viewing system must be greater than the presently available 12 in. of the system described in Attachment 3. Therefore, we propose to use that system and to modify to permit increased separation of the optical center lines of the viewing turrets without deterioration of the present optical performance. This modification is to be accomplished by changing the realy design. The intended changes will allow (a) Approximate . 18 in. separation of the viing turrets, (b) a fine focus adjustment, (c) the use of the instrument ovalarger scale differential, and (d) relaxation of the chip cut-out requirements.	e STAT it ew-
has considerable expertise in the extensiv	re STAT
modification of Dynazoom pods. We are using these po	
in conjunction with relay systems of our own design as demonstrated in	
the 80 power magnification system of the Type 880 and 1210 comp	
tors in use at the customer facility. Our modifications include changes	
from an angle to a straight line viewing system, replacement of objecti-	ves,
and addition of 1:1 relay systems. We have made necessary changes to	the
zoom feature and have centered objectives to permit magnification power	;r
changes without image shift.	
of the entired trains Our	
There is a requirement for a reticle in each of the optical trains. Our	cal
understanding is that the reticle in the scan (non-measuring) stage optic train is intended for use only in optical alignment of the film chips. For	r it
to remain in the system during actual measuring would produce eyestra	in.
Consequently, our design shall include a means for removal of this reti	icle
from the optical path during the measuring mode of operation.	
110m the optical pain auting the most of the first of the	
After a review of the Stereo-viewer which include the	se _{STAT}
of objectives, a check was made of comparative performance of	STAT
these and other objectives available in our laboratory. Tests and prior	r
experience indicate that the objective's characteristics include a	STAT
flatter resolution field than the comparable objectives.	STAT
detection and the second secon	uring
It is our intention to try these objectives in a system at an early date d	t
the contract to demonstrate expected system performance improvemen	to
If improvement is apparent, we plan to request a contract amendment substitute the bjectives for those specified in Attachment 3.	STAT
substitute thebjectives for those specified in Attachment 3.	
mit fourth and handle afforded by the new relay design is the ability to he	ave

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1	ustment for each leg of the system. This is a	STAT
system.		

Film Stage and Hold-down System

There shall be two film stages, each capable of handling film chips in sizes up to 6 in. \times 6 in.

Each of the film stages shall be supported on separate X-Y carriage assemblies.

Each of the X-Y carriage assemblies shall have independent translation of ±3 in. in both of the X axis and the Y axis. The carriage assemblies shall be mounted on a common Meehanite base. Each shall be supported by selected high precision ball bearings, and shall be guided using low-friction guide shoes spring-loaded against lapped guiding keys. This is proven technique employed on other precision instruments. The measuring stage construction shall permit a mechanical rotation of ±10° of its film support surface about the center of the clear aperture. The non-measuring stage construction shall permit a rotation of 360° of its film support surface about the clear aperture.

A feature requested is a variable differential drive between the two film stages to permit the scanning of two images of different scale in stereo, with the motions remotely controlled at the operator's console. Additionally, provision is requested for both independent and common drive speeds to range between 0.0002 in./sec and 1 in./sec.

Experience dictates that as the system response to change approaches true linearity, differential performance becomes more satisfactory and is useful over a larger range of differential travel. We believe that any attempt to operate in a range between 0.0002 in./sec and 1 in./sec would introduce non-linearities and degrade synchronism of the differential stage motions to a point of questionable usefulness.

Furthermore, experimental and analytical examination of the interrelationship between the required accuracy, desired magnification, and speed and control of approach to setting target establishes the need for a maximum slow-speed setting capability of 0.0002 in./sec. This, to some extent, determines the screw pitch and the maximum allowable speed rate.

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We propose lead screws of 5 mm lead per revolution to provide for transportation of the stages at 5 microns/sec, minimum speed and 5 mm/sec (1 revolution), maximum speed with a design goal of 0.5 in./sec for the maximum speed. If feasible, this limit shall become a part of the instrument performance specification. Since the distance between most points of interest on a film chip are small and can be traversed in a short time, the desire to obtain very high speeds coupled with the need to maintain precise control at the minimum speed introduces considerable and unwarranted expense. The gains achieved would be offset by the necessity for complex servos, as well as extra lubrication and cooling of the screws, and the introduction of operational problems. For example, the combination of a translation rate as high as 1 in./sec and the small field of view permitted by the optics are basically incompatible.

We propose to use four independent motors - one on each screw, with a single joystick control for all motors. Control shall be accomplished (remotely) with the console election of push button options, LEFT, RIGHT, BOTH for stage translation, and panel selection of variable differential drive over a five fold range (1:1 to 5:1) between the measuring stage and the non-measuring stage.

The motors shall be of the velocity servo type commonly used at the	STAT
on our fully automated Photorepeaters. Our experience	STAT
indicates that these motors should be adequate for the task at hand. It	
is understood that precise speed ratios with the attendent elaborate drives	
are not required.	

The film hold-down shall be accomplished using the manual upper film pressure plate such that at 200 power magnification the film shall remain flat and in sharp focus over a minimum area of 1 in. square. At lower powers, the film shall remain in sharp focus over the entire format.

Film Measurement System

One of the two film stages shall have a measuring capability. This measuring stage shall have two axis (X and Y) digitizers with a measuring range of ± 3 in. in both axes.

Two		Туре	H1045	enco	der hea	ads sha	ill be	geared	l thru	backlash	compens	TAT
										uring sta		
The	backla	sh co	mpens	ation	system	ı shall	perm	nit the n	measu	rement to	o be	
taker	ı in ei	ther	directio	n of	motion	of the	resp	ective a	stage.	This tee	chnique	

: :	December 7, 1967 STA	Γ
	has been successfully employed by the in its Type STA	Γ
	1032 Digital Microdensitometer and in the Type 1205 Automatic Comparator.	
f.	The accuracy of measurement shall be ±2 microns for measurement of 1	
W,11	in. or under. The requested accuracy of 1 part in 5000 over the entire film format shall be met or exceeded. Standard design of the	Γ
this acted	systems includes the specification of accuracy of 1 part in STATE 100,000. The orthogonality of the X and Y axes shall be within 5 sec of arc.	Γ
	The objective of maintaining the highest possible accuracy over short	
	distances may well be accomplished with the incorporation of standard	
	practices used in the manufacture of high precision comparators.	Γ

Measurement Read-out System

It is understood that the stereo comparator will have two film stages, which will be moved by two sets of X and Y lead screws. The lead screws will be driven by four velocity servos under the control of a joystick. The system will be arranged to allow moving the stages separately, together, or with one stage moving at a speed which is proportional to the speed of the other.

When the operator has made a setting on an image, he will command a position reading to be made. The digital values of the X and Y coordinates of one of the film stages will be automatically read, and these values along with other data inserted by the operator will be transmitted to a remote computer. The data system will then wait for an acknowledgment or error signal from the computer, and if necessary, the data will be automatically transmitted again.

The digital coordinate values will be derived from two optical encoders, one of which will be connected through gears to each of the X and Y lead screws of the measuring stage. The encoders will be driven by the gears at five times the speed of the screws. Each of the encoders will generate two voltages which will vary in a roughly sinusoidal manner as the encoder turns. Each voltage will complete 500 cycles per turn of the encoder, and the two voltages will be in phase quadrature. One of these voltages will be fed to a pulse-forming circuit in the data acquisition system, which circuit will produce 1000 pulses for each turn of the encoder. The other encoder output voltage will be used to determine the sense of encoder rotation. This arrangement will provide one pulse for each micron of stage motion.

The pulses from each encoder will be fed to a reversible counter. By adding or subtracting a count for each micron of stage motion, the counters will accumulate values which will provide a continuous indication of the X

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and Y coordinates of stage position. Provision will be made for resetting the counters to zero and for setting them to preset values selected by the operator. A switch for each counter will be provided for reversing the sense of counting. The coordinate values will be displayed to the operator on two Nixie tube displays. Each display will consist of six decimal digits plus sign.

On command, the data acquisition system will generate a signal in the specified format, and this signal will be fed through a cable to a remote computer. A signal generated by the computer acknowledging receipt of the message will be received by the system on another cable. It is understood that the cables and the connections to the computer are to be provided by the customer. It is also understood that the computer is located in the same building and the cable is not so long as to require compensating networks or special signal restoring amplifiers. Services for programming and operating the computer as required to check out and operate the system are to be provided by the customer.

The control panel, counters, signal processing circuits, power supplies, etc. will be mounted in a single cabinet. Integrated circuits on plug-in cards will be used for performing nearly all functions. In those cases where integrated circuits are not suitable for use because of their limited power handling ability, semiconductor circuits using discrete components will be used.

The Type of integrated circuit logic used will be TTL. Integrated circuits of this type, properly used, afford a high degree of immunity to noise, high speed, and excellent reliability. The availability of complex functions in a single TTL package reduces the number of interconnections and thereby further enhances reliability. Their small size allows placing much more logic on each card, reducing the number of cards required and further reducing the number of interconnections. The lower power requirements of integrated circuits as compared to discrete component circuits allows

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the use of smaller power supplies and effectively eliminates heat dissipation problems in most of the circuits.

Since fewer cards and less power are required by integrated circuits, it is feasible to design a more compact unit without sacrificing accessibility for service. It is understood that compact size, while preserving ready accessibility, is a required feature of the system.

Through careful circuit design and the use of large electrical margins, the counters and signal processing circuits will be made immune to outside interference and free of extraneous pulses. The counters will maintain a precise indication of stage position for indefinite periods of time. A high degree of reliability will be a prime design consideration.

The requirements for the proposed data acquisition system are well within the state of the art, and no unusual difficulty is seen in meeting all of the requirements. All of the techniques contemplated for use in the system have been fully tested and proven both by us and by others. We have designed and built a number of similar systems of equal or greater complexity. All of these systems have performed as intended and are in current use. It is recognized, however, that the proposed system is fairly complex and will require taking considerable care at all stages of design to insure a completely satisfactory result.

Stage Illumination

The stage illumination system is designed to meet the requirements of Section 4.5 of your request.

The film shall be supported on special glass platens inlet into the upper surfaces of the rotary and pivot tables. The upper surface of these 1/4 in. thick support platens shall be opalized to give maximum light for the high Numerical Aperture objectives used. Conventional Abbe' microscope illumination systems cannot be brought close enough to the film plane because of the glass pressure plates needed to hold the film flat. The manually operated pressure plates shall be hinged and pivoted at the rear to permit convenient operation. The microscope illumination shall be two independently controlled tungsten iodide lamps whose spectral output is filtered to remove the non-visible radiant (1 R) light. These light sources shall be remotely located in the bottom rear of the support console in such a manner and position that thermal heating is minimized and fan cooling may

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be eliminated. Air will, however, be directed across the upper film pressure platen and objective lens into to provide adequate film cooling. The general field of measurement shall be illuminated by fluorescent lamps located on the X axis stages and controlled by a switch on the instrument console.

The Control Console

The complete system shall be designed in accordance with correct ergonomic principles for easy, comfortable, rapid operation.

Electrical controls shall be provided for setting a 5 to 1 variable differential drive between the corresponding axes of the stages.

Continuously variable speed drive controls shall cover the range of 5 microns/sec to 5 mm/sec with a design objective of 0.5 in./sec for maximum speed.

The joystick, stage translation selector push button, the variable differential selector, and independent controls for intensity variation shall all be located conveniently at the front of the console on which the comparator is mounted. The measurement readout system including power supply display shall be located in a separate Emcor II rack. An artist's conception of these units is attached.

Overall Physical Consideration

The console shall be a rigid steel weldment providing support for the comparator section and its controls. The console shall meet the specified size requirements and shall be provided with suitable casters and leveling for portability and leveling. The leveling jacks shall terminate in vibration isolators to provide protection against local external vibrations.

The environment of a system is extremely important when precision of	
measurement is to be maintained. While the instrument is unaffected, we	
believe that the conditions specified in your Request for Proposal are not	
sufficient for maintenance of the precision stated elsewhere in your request	•
The following is a statement of practices recommended by the	STAT
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"Precise measurement is a function of not only the instrument involved and its operator but also of the environment in which both perform.

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	nough to permit free access and operation of wely free of contaminants such as dust.
These units should not only	a "clean room" or "clean bench" is recommended. supply a clean, filtered air flow over the
numidity as well. The air f	vide a control of temperature and relative low rate should not exceed 3 to 4 miles per hour sudden temperature shears.
	lated to ±1°F and be known. For work with erials, a relative humidity of 50% ±5% is
Shielding shall be provided to re RFI.	hroughout the system so that no critical circuits
Reliability and Service Time	<u>. </u>
usage, under normal operations over day operation; with and with only minor mainten parts.	equipment shall be designed to withstand service ing conditions, for a period of 500 hours (5 hout significant degradation of performance, ance due to normal expendable replacement ease of assembly and disassembly, (2) ready
	ources, (3) maintenance with tools and equip- maintenance personnel, and (4) external test
Miscellaneous	
Recommended spare parts 1:	shall provide the following: (1) Operators stenance Manual (including schematics), (3) ist, including the cost of each item and the total secification DB-1003, dated August 31, 1966).
o permit the most reliable	ing lights, and safety features shall be included and safe operation of the instrument possible. Lently located and readily accessible.
Reporting	
Гhе	agrees to comply with reporting procedures STAT

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as stated in specification DB-1003.

CONCLUSION

As indicated in our introduction, the need for the above described Twin Stage On-Line Comparator appears to be of sufficient importance that every effort should be made to give consideration to the most flexible and useful design possible. We believe it is both theoretically feasible and practical to fabricate the instrument described in our proposal. Each of the problems anticipated in the manufacture of the instrument have been described in the section of concern.